## Application/Control No. Applicant(s)/Patent Under Reexamination 10/629,835 FURUMIYA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2627 Kim-Kwok CHU **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 369/59.12 US-7,095,696 08-2006 Nakajima et al. Α US-B. С US-US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R

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